

**Features**

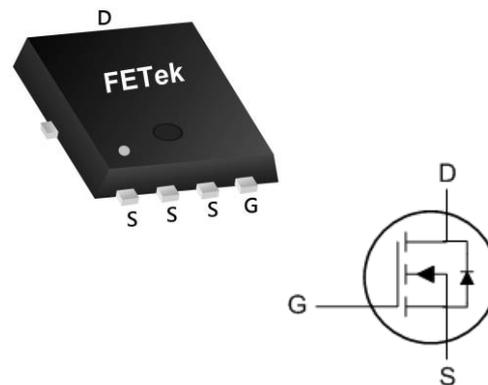
- Advanced Trench MOS Technology
- 100% EAS Guaranteed
- High Current Capability
- Green Device Available

**Applications**

- SMPS Synchronous Rectification
- DC/DC Converters
- Or-ing

**Product Summary**


| BVDSS | RDSON | ID   |
|-------|-------|------|
| 40V   | 1mΩ   | 220A |

**PRPAK5X6 Pin Configuration**

**Absolute Maximum Ratings**

| Symbol                | Parameter                                      | Rating     | Units      |
|-----------------------|--|------------|------------|
| $V_{DS}$              | Drain-Source Voltage                           | 40         | V          |
| $V_{GS}$              | Gate-Source Voltage                            | $\pm 20$   | V          |
| $I_D@T_C=25^\circ C$  | Continuous Drain Current, $V_{GS} @ 10V^{1,6}$ | 220        | A          |
| $I_D@T_C=100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V^{1,6}$ | 140        | A          |
| $I_{DM}$              | Pulsed Drain Current <sup>2</sup>              | 400        | A          |
| EAS                   | Single Pulse Avalanche Energy <sup>3</sup>     | 562        | mJ         |
| $I_{AS}$              | Avalanche Current                              | 106        | A          |
| $P_D@T_C=25^\circ C$  | Total Power Dissipation <sup>4</sup>           | 89         | W          |
| $T_{STG}$             | Storage Temperature Range                      | -55 to 150 | $^\circ C$ |
| $T_J$                 | Operating Junction Temperature Range           | -55 to 150 | $^\circ C$ |

**Thermal Data**

| Symbol          | Parameter  | Typ. | Max. | Unit         |
|-----------------|--|------|------|--------------|
| $R_{\theta JA}$ | Thermal Resistance Junction-Ambient <sup>1</sup> | ---  | 62   | $^\circ C/W$ |
| $R_{\theta JC}$ | Thermal Resistance Junction-Case <sup>1</sup>    | ---  | 1.4  | $^\circ C/W$ |

**Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)**

| Symbol              | Parameter                                      | Conditions   | Min. | Typ. | Max. | Unit |
|---------------------|--|--|------|------|------|------|
| BV <sub>DSS</sub>   | Drain-Source Breakdown Voltage                 | V <sub>GS</sub> =0V, I <sub>D</sub> =250uA   | 40   | ---  | ---  | V    |
| R <sub>DS(ON)</sub> | Static Drain-Source On-Resistance <sup>2</sup> | V <sub>GS</sub> =10V, I <sub>D</sub> =20A  | ---  | 0.8  | 1.0  | mΩ   |
|                     |  | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A   | ---  | 1.2  | 2.0  |      |
| V <sub>GS(th)</sub> | Gate Threshold Voltage                         | V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA                                 | 1.2  | 1.7  | 2.2  | V    |
| I <sub>DSS</sub>    | Drain-Source Leakage Current                   | V <sub>DS</sub> =32V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C                          | ---  | ---  | 1    | uA   |
|                     |  | V <sub>DS</sub> =32V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C                          | ---  | ---  | 5    |      |
| I <sub>GSS</sub>    | Gate-Source Leakage Current                    | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V   | ---  | ---  | ±100 | nA   |
| R <sub>g</sub>      | Gate Resistance                                | V <sub>DS</sub> =0V, V <sub>GS</sub> =0V, f=1MHz   | ---  | 1.3  | ---  | Ω    |
| Q <sub>g</sub>      | Total Gate Charge (10V)                        | V <sub>DS</sub> =20V, V <sub>GS</sub> =10V, I <sub>D</sub> =20A                          | ---  | 126  | ---  | nC   |
| Q <sub>g</sub>      | Total Gate Charge (4.5V)                       |  | ---  | 66   | ---  |      |
| Q <sub>gs</sub>     | Gate-Source Charge                             |  | ---  | 17   | ---  |      |
| Q <sub>gd</sub>     | Gate-Drain Charge                              |  | ---  | 28   | ---  |      |
| T <sub>d(on)</sub>  | Turn-On Delay Time                             | V <sub>DD</sub> =20V, V <sub>GS</sub> =10V, R <sub>G</sub> =1.5Ω,<br>I <sub>D</sub> =20A | ---  | 15   | ---  | ns   |
| T <sub>r</sub>      | Rise Time                                      |  | ---  | 41   | ---  |      |
| T <sub>d(off)</sub> | Turn-Off Delay Time                            |  | ---  | 58   | ---  |      |
| T <sub>f</sub>      | Fall Time                                      |  | ---  | 30   | ---  |      |
| C <sub>iss</sub>    | Input Capacitance                              | V <sub>DS</sub> =20V, V <sub>GS</sub> =0V, f=1MHz  | ---  | 6780 | ---  | pF   |
| C <sub>oss</sub>    | Output Capacitance                             |  | ---  | 2100 | ---  |      |
| C <sub>rss</sub>    | Reverse Transfer Capacitance                   |  | ---  | 225  | ---  |      |

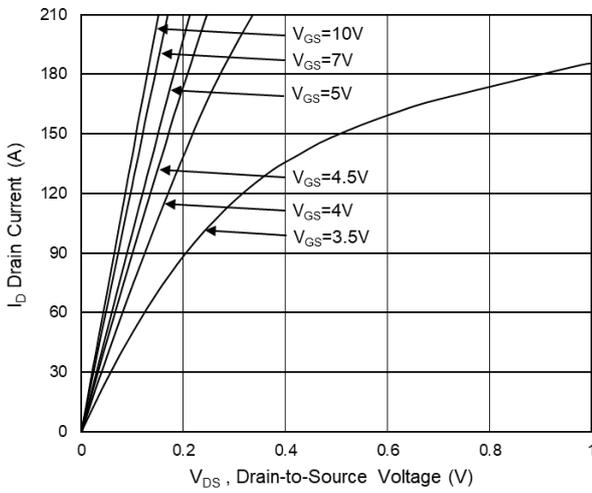
**Diode Characteristics**

| Symbol          | Parameter                                | Conditions  | Min. | Typ. | Max. | Unit |
|-----------------|--|---|------|------|------|------|
| I <sub>S</sub>  | Continuous Source Current <sup>1,6</sup> | V <sub>G</sub> =V <sub>D</sub> =0V, Force Current             | ---  | ---  | 100  | A    |
| V <sub>SD</sub> | Diode Forward Voltage <sup>2</sup>       | V <sub>GS</sub> =0V, I <sub>S</sub> =1A, T <sub>J</sub> =25°C | ---  | ---  | 1.2  | V    |

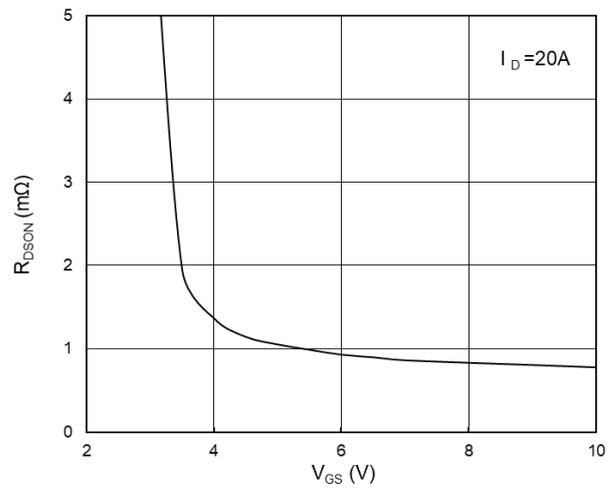
Note :

- The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%
- The EAS data shows Max. rating. The test condition is V<sub>DD</sub>=25V, V<sub>GS</sub>=10V, L=0.1mH, I<sub>AS</sub>=106A
- The power dissipation is limited by 150°C junction temperature
- The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.
- Package limitation current is 100A.

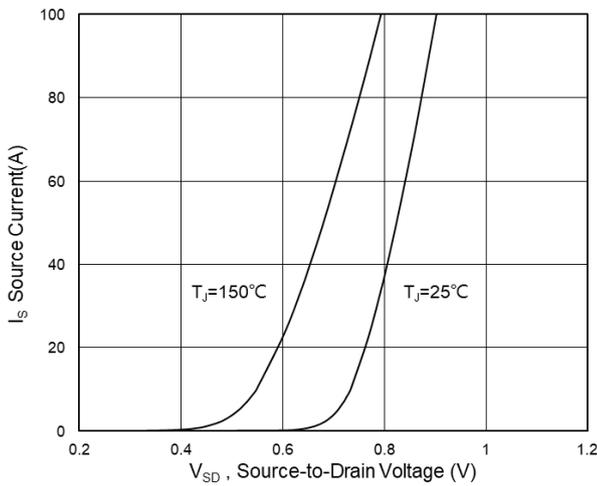
**Typical Characteristics**



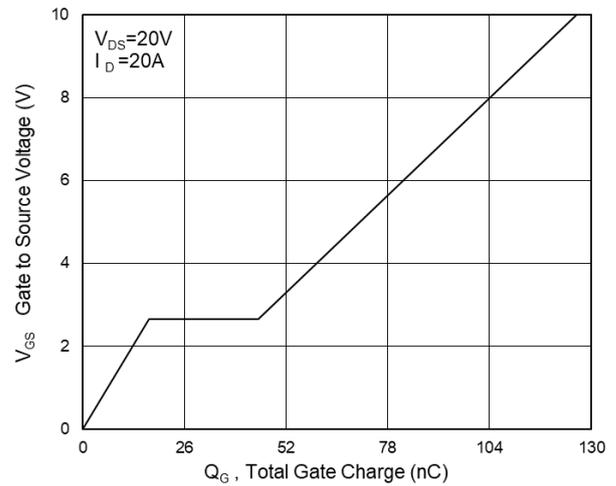
**Fig.1 Typical Output Characteristics**



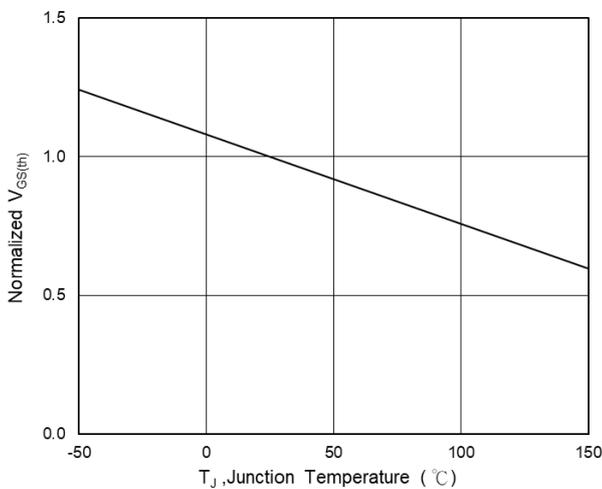
**Fig.2 On-Resistance vs G-S Voltage**



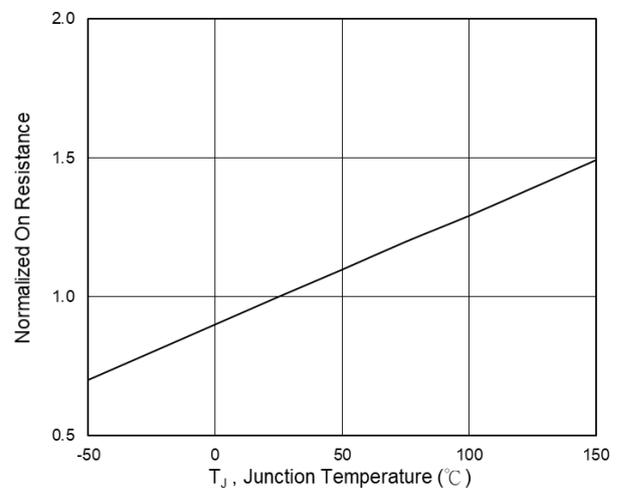
**Fig.3 Source Drain Forward Characteristics**



**Fig.4 Gate-Charge Characteristics**



**Fig.5 Normalized  $V_{GS(th)}$  vs  $T_J$**



**Fig.6 Normalized  $R_{DS(on)}$  vs  $T_J$**

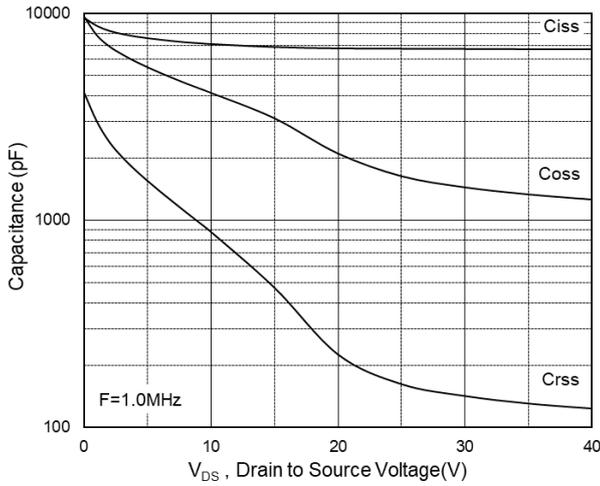


Fig.7 Capacitance

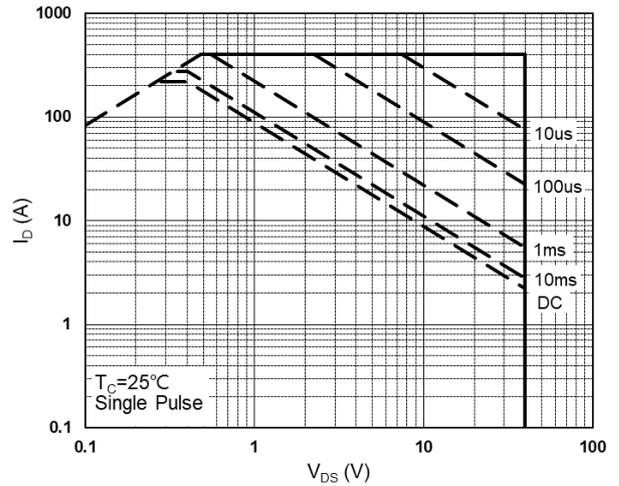


Fig.8 Safe Operating Area

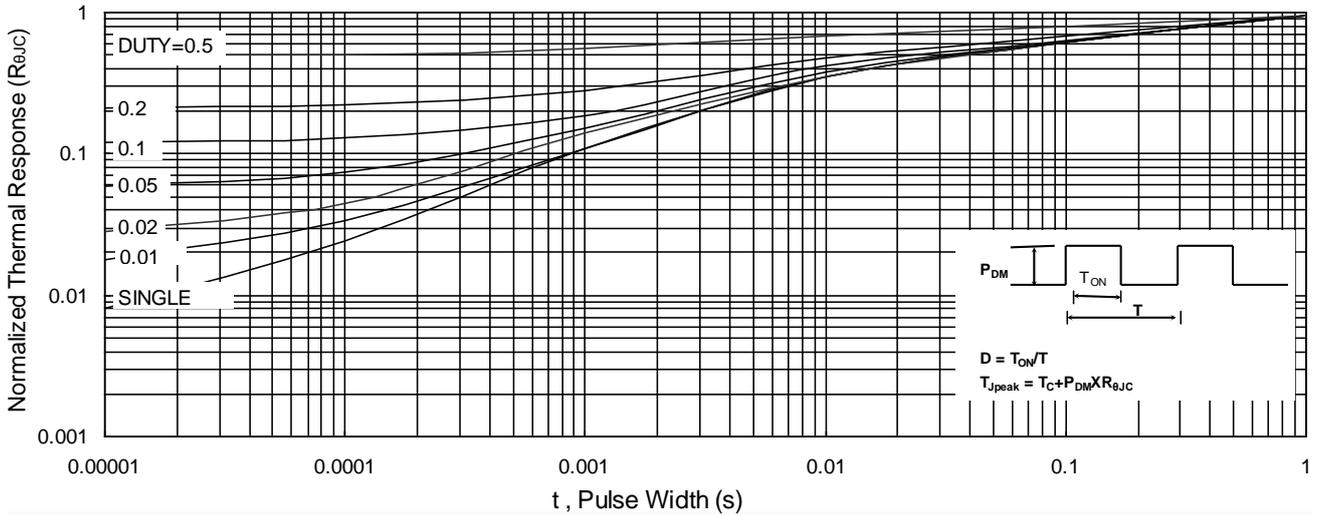


Fig.9 Normalized Maximum Transient Thermal Impedance

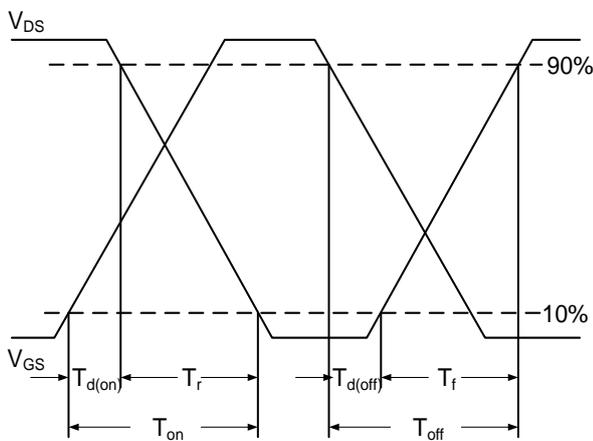


Fig.10 Switching Time Waveform

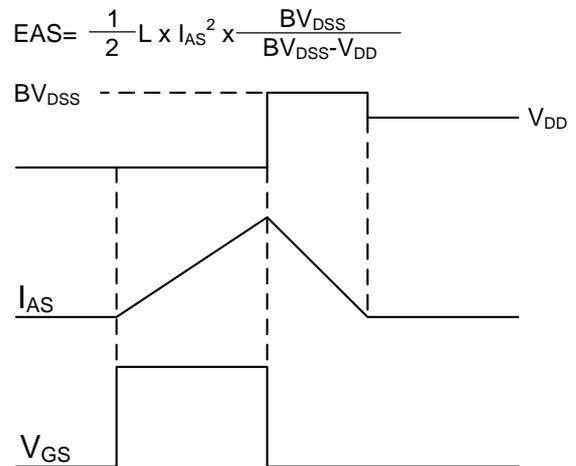


Fig.11 Unclamped Inductive Switching Waveform